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Application/Control No.	Applicant(s)/Patent under Reexamination		
10/573,823	ITO, YASUSHI		
Examiner	Art Unit		
Hai H. Huynh	3747		

	CEAD	CHED	
	SEAR	CHED	
Class	Subclass	Date	Examiner
123	1A	2/28/2007	ннн
123	27GE	2/28/2007	ннн
123	525	2/28/2007	ННН
123	527	2/28/2007	ннн
123	575	2/28/2007	ннн
123	304	2/28/2007	ннн
123	431	2/28/2007	ннн
123	DIG12	2/28/2007	ннн

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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		DATE	EXMR
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